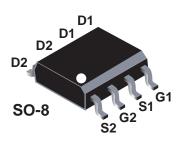


Dual Notebook Power Supply N-Channel PowerTrench[®] SyncFet[™]

General Description

The FDS6982S is designed to replace two single SO-8 MOSFETs and Schottky diode in synchronous DC:DC power supplies that provide various peripheral voltages for notebook computers and other battery powered electronic devices. FDS6982S contains two unique 30V, N-channel, logic level, PowerTrench MOSFETs designed to maximize power conversion efficiency.

The high-side switch (Q1) is designed with specific emphasis on reducing switching losses while the low-side switch (Q2) is optimized to reduce conduction losses. Q2 also includes an integrated Schottky diode using Fairchild's monolithic SyncFET technology.



Features

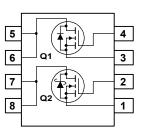
• Q2: Optimized to minimize conduction losses Includes SyncFET Schottky body diode

8.6A, 30V $R_{DS(on)} = 0.016\Omega @ V_{GS} = 10V$

 $R_{DS(on)} = 0.022\Omega @ V_{GS} = 4.5V$

• Q1: Optimized for low switching losses Low Gate Charge (8.5 nC typical)

6.3A, 30V $R_{DS(on)} = 0.028\Omega @V_{GS} = 10V$ $R_{DS(on)} = 0.035\Omega @V_{GS} = 4.5V$



Absolute Maximum Ratings $T_{A} = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter			Q2	Q1	Units	
V _{DSS}	Drain-Source Voltage			30	30	V	
V _{GSS}	Gate-Source Voltage			±20	±20	V	
I _D	Drain Current	t - Continuous	(Note 1a)	8.6	6.3	А	
		- Pulsed		30	20		
P _D	Power Dissipation for Dual Operation			2		W	
	Power Dissipation for Single Operation (Note 1a)			1			
			(Note 1b)		1		
			(Note 1c)	0	.9		
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 tc	°C		
Therma	I Charact	eristics					
R _{0JA}	Thermal Resistance, Junction-to-Ambient (Note 1a)		7	°C/W			
R _{θJC}	Thermal Resistance, Junction-to-Case (Note 1)			4	°C/W		
Packag	e Marking	and Ordering I	nformation			·	
Device Marking		Device	Reel Size	Tape width		Quantity	
FDS6982S		FDS6982S	13"	12mm	1	2500 units	

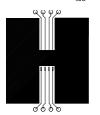
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Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Cha	racteristics	I					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_D = 1 mA$ $V_{GS} = 0 V, I_D = 250 uA$	Q2 Q1	30 30			V
∆BV _{DSS}	Breakdown Voltage	$I_{D} = 1 \text{ mA}$. Referenced to 25°C	Q1 Q2	30	20		mV/°C
ΔT_{J}	Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C	Q1		26		
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$	Q2 Q1			500 1	μA
IGSSF	Gate-Body Leakage, Forward	V _{GS} = 20 V, V _{DS} = 0 V	All			100	nA
I _{GSSR}	Gate-Body Leakage, Reverse	V _{GS} = -20 V, V _{DS} = 0 V	All			-100	nA
On Cha	racteristics (Note 2)						
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 1 \text{ mA}$	Q2	1		3	V
		V _{DS} = V _{GS} , I _D = 250 μA	Q1	1		3	
$\Delta V_{GS(th)}$	Gate Threshold Voltage	I_D = 1 mA, Referenced to 25°C	Q2		-3.5		mV/°C
	Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25° C	Q1		-5	0.040	-
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = 10 V, I_D = 8.6 A$	Q2		0.013 0.020	0.016 0.027	Ω
	OII-Resistance	V_{GS} = 10 V, I_D = 8.6 A, T_J = 125°C V_{GS} = 4.5 V, I_D = 7.5 A			0.020	0.027	
		$V_{GS} = 4.5 \text{ V}, I_D = 7.5 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 6.3 \text{ A}$	Q1		0.021	0.022	
			QI		0.021	0.020	
		$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 6.3 \text{ A}, \text{ T}_{J} = 125^{\circ}\text{C}$			0.038	0.035	
	On Otata Duala Original	$V_{GS} = 4.5 V, I_D = 5.6 A$ $V_{GS} = 10 V, V_{DS} = 5 V$	00	20	0.020	0.000	
I _{D(on)}	On-State Drain Current	$V_{GS} = 10 V, V_{DS} = 5 V$	Q2	30 20			А
-	Forward Transconductance	V _{DS} = 5 V. I _D = 8.6 A	Q1	20	20		S
g fs	Forward Transconductance	$V_{DS} = 5 V, I_D = 8.6 A$ $V_{DS} = 5 V, I_D = 6.3 A$	Q2 Q1		38 18		5
		$v_{DS} = 5 v, I_D = 0.5 A$	QI		10		
Dynami	c Characteristics						
Ciss	Input Capacitance	$V_{DS} = 10 V, V_{GS} = 0 V,$	Q2		2040		pF
- 135		f = 1.0 MHz	Q1		815		P
Coss	Output Capacitance		Q2		615		pF
0055			Q1		186		μ.
C _{rss}	Reverse Transfer Capacitance		Q2		216		pF
- 155			Q1		66		۳.

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Мах	Units
Switchir	ng Characteristics (Note	2)					
t _{d(on)}	Turn-On Delay Time	V_{DD} = 15 V, I _D = 1 A, V _{GS} = 10V, R _{GEN} = 6 Ω	Q2 Q1		10 10	18 18	ns
t _r	Turn-On Rise Time		Q2 Q1		10 14	18 25	ns
t _{d(off)}	Turn-Off Delay Time		Q2 Q1		34 21	55 34	ns
t _f	Turn-Off Fall Time		Q2 Q1		14 7	23 14	ns
Qg	Total Gate Charge	Q2 V _{DS} = 15 V, I _D = 11.5 A, V _{GS} = 5 V	Q2 Q1		17.5 8.5	25 12	nC
Q _{gs}	Gate-Source Charge	Q1	Q2 Q1		6.3 2.4		nC
Q _{gd}	Gate-Drain Charge	V_{DS} = 15 V, I_D = 6.3 A, V_{GS} = 5 V	Q2 Q1		5.4 3.1		nC
Drain-S	ource Diode Character	istics and Maximum Rating	S				
ls	Maximum Continuous Drain-Source Diode Forward Current					3.0 1.3	A
t _{RR}	Reverse Recovery Time	I _F = 11.5A,	Q2		20		ns
Q _{RR}	Reverse Recovery Charge	$d_{iF}/d_t = 300 \text{ A}/\mu \text{s} \qquad (\text{Note 3})$			19.7		nC
V _{SD}	Drain-Source Diode Forward Voltage	$ \begin{array}{ll} V_{GS} = 0 \ V, \ I_S = 3 \ A & (Note \ 2) \\ V_{GS} = 0 \ V, \ I_S = 6 \ A & (Note \ 2) \\ V_{GS} = 0 \ V, \ I_S = 1.3 \ A & (Note \ 2) \end{array} $	Q2 Q2 Q1		0.42 0.56 0.70	.7 1.2	V

Notes:

1. R_{8JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $\rm R_{\theta JC}$ is guaranteed by design while $\rm R_{\theta CA}$ is determined by the user's board design.





Q Q Q Q Qb) 125°/W when mounted on a .02 in² pad of 2 oz copper

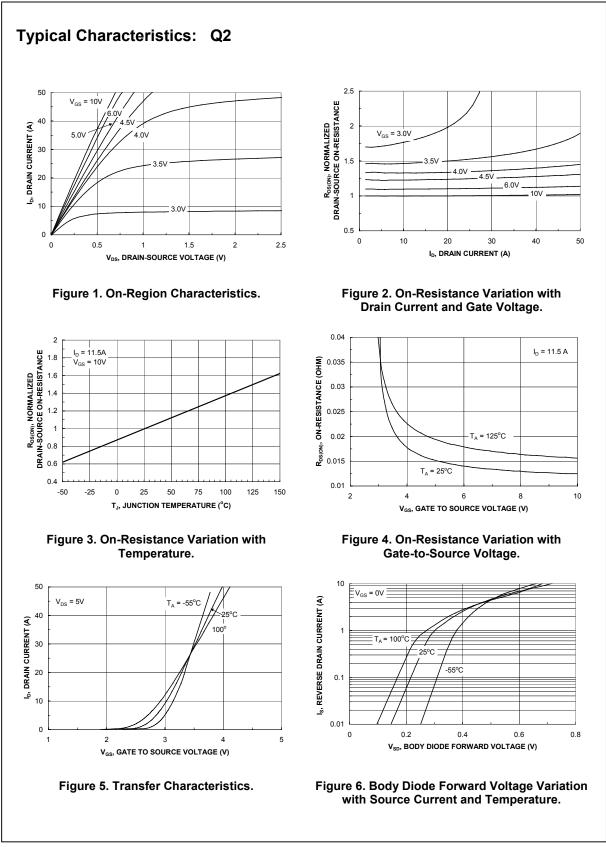
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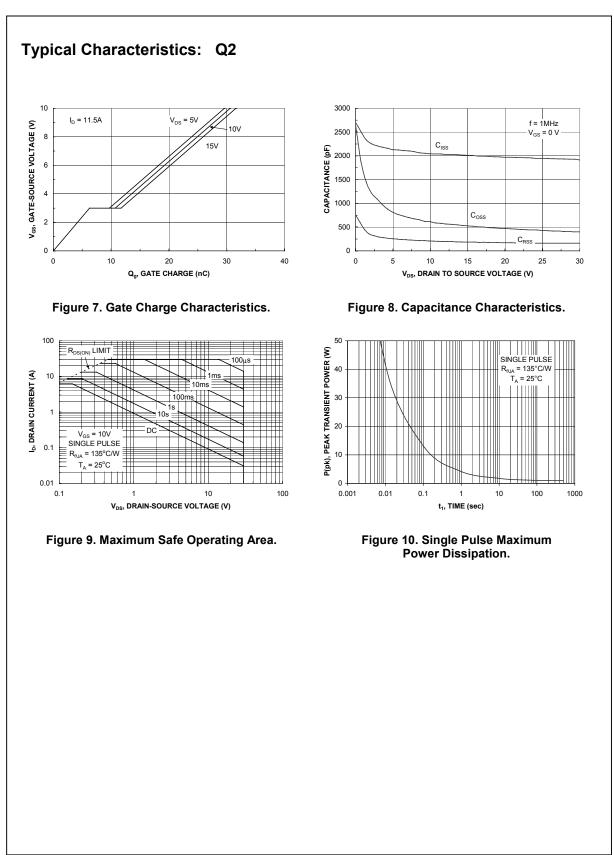
c) 135°/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

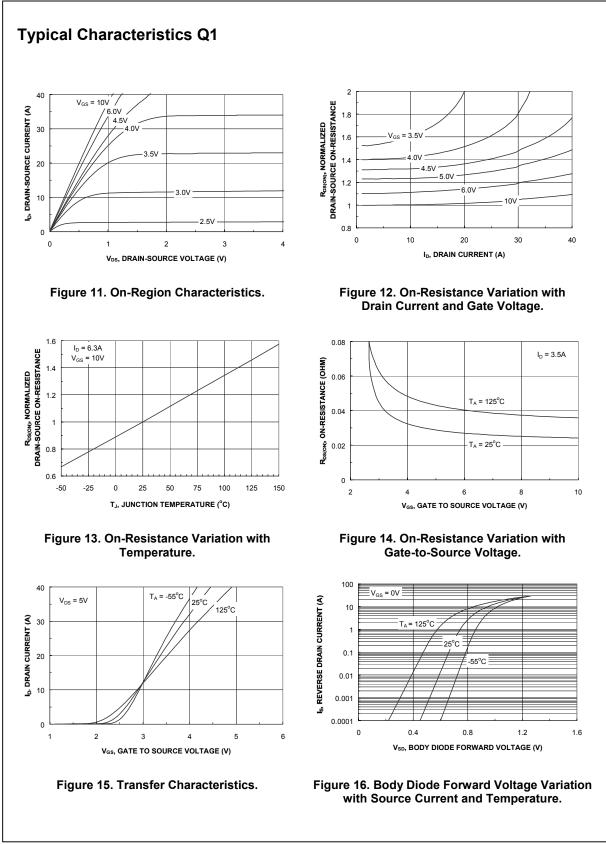
3. See "SyncFET Schottky body diode characteristics" below.

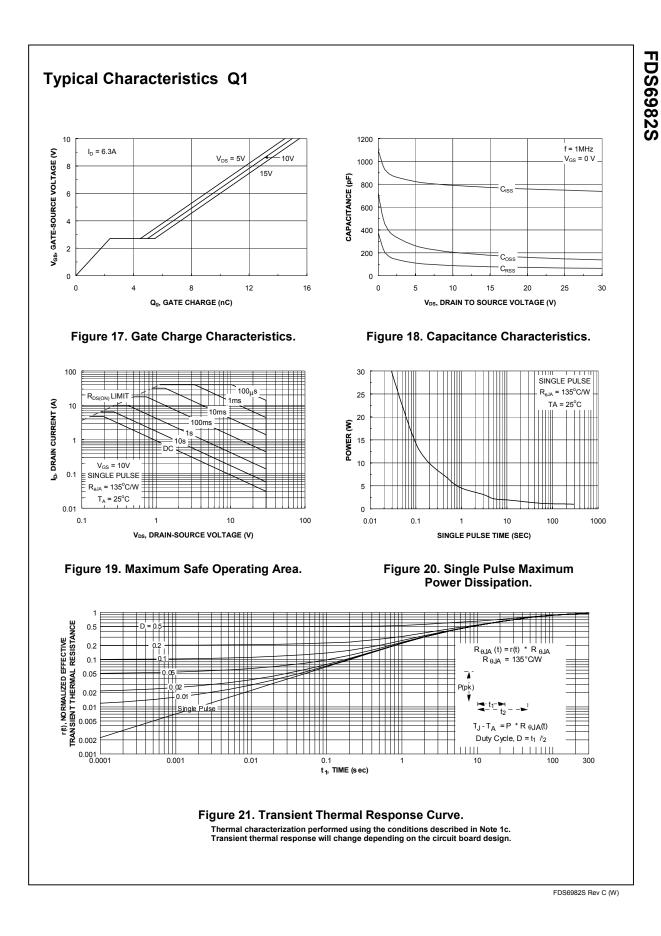




FDS6982S Rev C (W)

FDS6982S

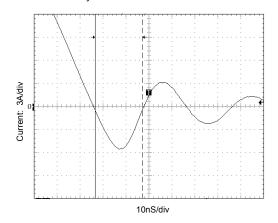




### Typical Characteristics (continued)

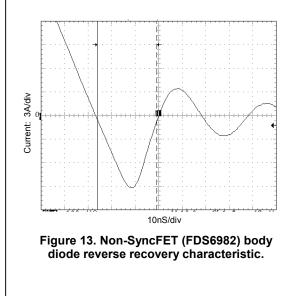
# SyncFET Schottky Body Diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 12 shows the reverse recovery characteristic of the FDS6982S.



## Figure 12. FDS6982S SyncFET body diode reverse recovery characteristic.

For comparison purposes, Figure 13 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDS6982).



Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

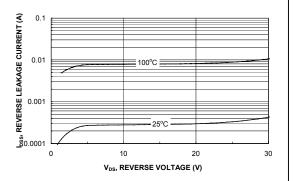


Figure 14. SyncFET body diode reverse leakage versus drain-source voltage and temperature.

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